# 3.3V CMOS OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOP WITH 3-STATE OUTPUTS AND 5 VOLT TOLERANT I/O

**IDT74LVC574A**

## FEATURES:

- **0.5 MICRON CMOS Technology**
- **ESD > 2000V per MIL-STD-883, Method 3015; > 200V using machine model (C = 200pF, R = 0)**
- **Vcc = 3.3V ± 0.3V, Normal Range**
- **Vcc = 2.7V to 3.6V, Extended Range**
- **CMOS power levels (0.4µ W typ. static)**
- **Rail-to-rail output swing for increased noise margin**
- **All inputs, outputs, and I/O are 5V tolerant**
- **Supports hot insertion**
- **Available in SOIC, SSOP, QSOP, and TSSOP packages**

## DRIVE FEATURES:

- **High Output Drivers: ±24mA**
- **Reduced system switching noise**

## APPLICATIONS:

- **5V and 3.3V mixed voltage systems**
- **Data communication and telecommunication systems**

## DESCRIPTION:

The LVC574A octal edge-triggered D-type flip-flop is built using advanced dual-metal CMOS technology. The device features 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. The LVC574A is particularly suitable for implementing buffer registers, input-output (I/O) ports, bidirectional bus drivers, and working registers.

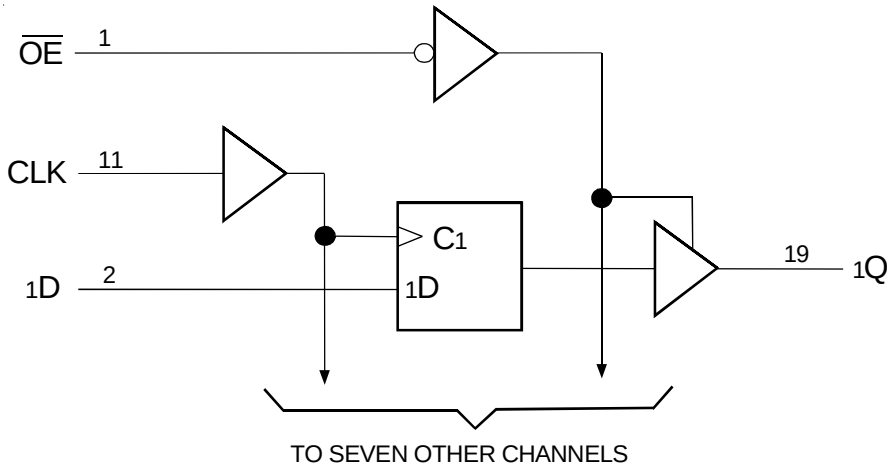
On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels at the data (D) inputs.

A buffered output-enable ($\overline{OE}$) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. $\overline{OE}$ does not affect the internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

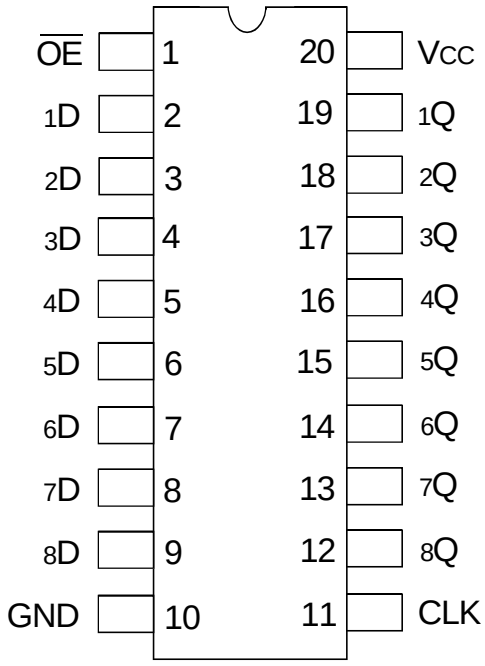
The LVC574A has been designed with a ±24mA output driver. This driver is capable of driving a moderate to heavy load while maintaining speed performance.

Inputs can be driven from either 3.3V or 5V devices. This feature allows the use of this device as a translator in a mixed 3.3V/5V system environment.

## FUNCTIONAL BLOCK DIAGRAM



## PIN CONFIGURATION




**SOIC/ SSOP/ QSOP/ TSSOP**
**TOP VIEW**

## ABSOLUTE MAXIMUM RATINGS(1)

| Symbol | Description | Max | Unit |
|---|---|---|---|
| $V_{TERM}$ | Terminal Voltage with Respect to GND | –0.5 to +6.5 | V |
| $T_{STG}$ | Storage Temperature | –65 to +150 | °C |
| $I_{OUT}$ | DC Output Current | –50 to +50 | mA |
| $I_{IK}$<br>$I_{OK}$ | Continuous Clamp Current,<br>$V_I < 0$ or $V_O < 0$ | –50 | mA |
| $I_{CC}$<br>$I_{SS}$ | Continuous Current through each<br>$V_{CC}$ or GND | ±100 | mA |

**NOTE:**
1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

## CAPACITANCE ($T_A$ = +25°C, F = 1.0MHz)

| Symbol | Parameter(1) | Conditions | Typ. | Max. | Unit |
|---|---|---|---|---|---|
| $C_{IN}$ | Input Capacitance | $V_{IN}$ = 0V | 4.5 | 6 | pF |
| $C_{OUT}$ | Output Capacitance | $V_{OUT}$ = 0V | 5.5 | 8 | pF |
| $C_{I/O}$ | I/O Port Capacitance | $V_{IN}$ = 0V | 6.5 | 8 | pF |

**NOTE:**
1. As applicable to the device type.

## PIN DESCRIPTION

| Pin Names | Description |
|---|---|
| $\overline{OE}$ | Output Enable Inputs (Active LOW) |
| CLK | Clock Input |
| xD | Data Inputs |
| xQ | 3-State Outputs |

## FUNCTION TABLE (EACH FLIP-FLOP)(1)

| Inputs | | | Outputs |
|---|---|---|---|
| $\overline{OE}$ | CLK | xD | xQ |
| L | ↑ | H | H |
| L | ↑ | L | L |
| L | H or L | X | Q(2) |
| H | X | X | Z |

**NOTES:**
1. H = HIGH Voltage Level
   X = Don't Care
   L = LOW Voltage Level
   Z = High-Impedance
   ↑ = LOW-to-HIGH Transition
2. Output level before the indicated steady-state input conditions were established.

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:
Operating Condition: $T_A$ = –40°C to +85°C

| Symbol | Parameter | Test Conditions | | Min. | Typ.(1) | Max. | Unit |
|---|---|---|---|---|---|---|---|
| $V_{IH}$ | Input HIGH Voltage Level | $V_{CC}$ = 2.3V to 2.7V | | 1.7 | — | — | V |
| | | $V_{CC}$ = 2.7V to 3.6V | | 2 | — | — | |
| $V_{IL}$ | Input LOW Voltage Level | $V_{CC}$ = 2.3V to 2.7V | | — | — | 0.7 | V |
| | | $V_{CC}$ = 2.7V to 3.6V | | — | — | 0.8 | |
| $I_{IH}$<br>$I_{IL}$ | Input Leakage Current | $V_{CC}$ = 3.6V | $V_I$ = 0 to 5.5V | — | — | ±5 | µA |
| $I_{OZH}$<br>$I_{OZL}$ | High Impedance Output Current (3-State Output pins) | $V_{CC}$ = 3.6V | $V_O$ = 0 to 5.5V | — | — | ±10 | µA |
| $I_{OFF}$ | Input/Output Power Off Leakage | $V_{CC}$ = 0V, $V_{IN}$ or $V_O \leq$ 5.5V | | — | — | ±50 | µA |
| $V_{IK}$ | Clamp Diode Voltage | $V_{CC}$ = 2.3V, $I_{IN}$ = –18mA | | — | –0.7 | –1.2 | V |
| $V_H$ | Input Hysteresis | $V_{CC}$ = 3.3V | | — | 100 | — | mV |
| $I_{CCL}$<br>$I_{CCH}$ | Quiescent Power Supply Current | $V_{CC}$ = 3.6V | $V_{IN}$ = GND or $V_{CC}$ | — | — | 10 | µA |
| $I_{CCZ}$ | | | $3.6 \leq V_{IN} \leq 5.5V$(2) | — | — | 10 | |
| $\Delta I_{CC}$ | Quiescent Power Supply Current Variation | One input at $V_{CC}$ - 0.6V, other inputs at $V_{CC}$ or GND | | — | — | 500 | µA |

**NOTES:**
1. Typical values are at $V_{CC}$ = 3.3V, +25°C ambient.
2. This applies in the disabled state only.

## OUTPUT DRIVE CHARACTERISTICS

| Symbol | Parameter | Test Conditions(1) | | Min. | Max. | Unit |
|---|---|---|---|---|---|---|
| $V_{OH}$ | Output HIGH Voltage | $V_{CC}$ = 2.3V to 3.6V | $I_{OH}$ = – 0.1mA | $V_{CC}$ – 0.2 | — | V |
| | | $V_{CC}$ = 2.3V | $I_{OH}$ = – 6mA | 2 | — | |
| | | $V_{CC}$ = 2.3V | $I_{OH}$ = – 12mA | 1.7 | — | |
| | | $V_{CC}$ = 2.7V | | 2.2 | — | |
| | | $V_{CC}$ = 3V | | 2.4 | — | |
| | | $V_{CC}$ = 3V | $I_{OH}$ = – 24mA | 2.2 | — | |
| $V_{OL}$ | Output LOW Voltage | $V_{CC}$ = 2.3V to 3.6V | $I_{OL}$ = 0.1mA | — | 0.2 | V |
| | | $V_{CC}$ = 2.3V | $I_{OL}$ = 6mA | — | 0.4 | |
| | | | $I_{OL}$ = 12mA | — | 0.7 | |
| | | $V_{CC}$ = 2.7V | $I_{OL}$ = 12mA | — | 0.4 | |
| | | $V_{CC}$ = 3V | $I_{OL}$ = 24mA | — | 0.55 | |

**NOTE:**
1. $V_{IH}$ and $V_{IL}$ must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate $V_{CC}$ range. $T_A$ = – 40°C to + 85°C.

## OPERATING CHARACTERISTICS, $V_{CC}$ = 3.3V ± 0.3V, $T_A$ = 25°C

| Symbol | Parameter | Test Conditions | Typical | Unit |
|---|---|---|---|---|
| $C_{PD}$ | Power Dissipation Capacitance per Flip-Flop Outputs enabled | $C_L$ = 0pF, f = 10Mhz | 43 | pF |
| $C_{PD}$ | Power Dissipation Capacitance per Flip-Flop Outputs disabled | | 15 | |

## SWITCHING CHARACTERISTICS(1)

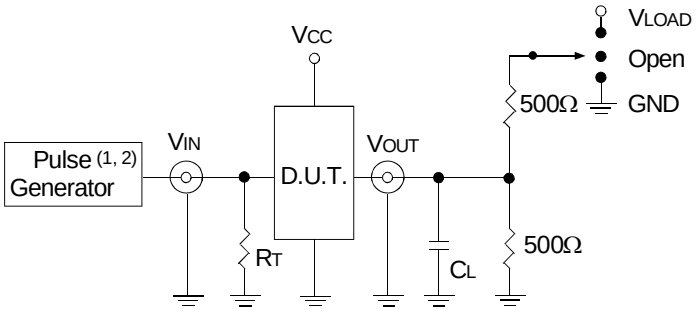
| Symbol | Parameter | Vcc = 2.7V | | Vcc = 3.3V ± 0.3V | | Unit |
|---|---|---|---|---|---|---|
| | | Min. | Max. | Min. | Max. | |
| $f_{MAX}$ | | 150 | — | 150 | — | MHz |
| $t_{PLH}$<br>$t_{PHL}$ | Propagation Delay<br>CLK to xQ | — | 8 | 2.2 | 7 | ns |
| $t_{PZH}$<br>$t_{PZL}$ | Output Enable Time<br>$\overline{OE}$ to xQ | — | 8.5 | 1.5 | 7.5 | ns |
| $t_{PHZ}$<br>$t_{PLZ}$ | Output Disable Time<br>$\overline{OE}$ to xQ | — | 7 | 1.7 | 6.4 | ns |
| $t_W$ | Pulse Duration, CLK HIGH or LOW | 3.3 | — | 3.3 | — | ns |
| $t_{SU}$ | Set-up Time, data before CLK↑ | 2 | — | 2 | — | ns |
| $t_H$ | Hold Time, data after CLK↑ | 1.5 | — | 1.5 | — | ns |
| $t_{SK}(o)$ | Output Skew(2) | — | — | — | 1 | ns |

**NOTES:**
1. See TEST CIRCUITS AND WAVEFORMS. $T_A$ = – 40°C to + 85°C.
2. Skew between any two outputs of the same package and switching in the same direction.

# TEST CIRCUITS AND WAVEFORMS

## TEST CONDITIONS

| Symbol | $V_{CC}^{(1)}$=3.3V±0.3V | $V_{CC}^{(1)}$=2.7V | $V_{CC}^{(2)}$=2.5V±0.2V | Unit |
|---|---|---|---|---|
| $V_{LOAD}$ | 6 | 6 | 2 x Vcc | V |
| $V_{IH}$ | 2.7 | 2.7 | Vcc | V |
| $V_T$ | 1.5 | 1.5 | Vcc / 2 | V |
| $V_{LZ}$ | 300 | 300 | 150 | mV |
| $V_{HZ}$ | 300 | 300 | 150 | mV |
| $C_L$ | 50 | 50 | 30 | pF |

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***Test Circuit for All Outputs***

**DEFINITIONS:**

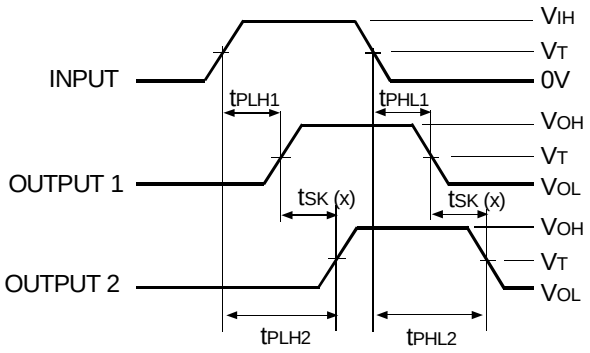
$C_L$ = Load capacitance: includes jig and probe capacitance.
$R_T$ = Termination resistance: should be equal to $Z_{OUT}$ of the Pulse Generator.

**NOTES:**

1. Pulse Generator for All Pulses: Rate ≤ 10MHz; $t_F$ ≤ 2.5ns; $t_R$ ≤ 2.5ns.
2. Pulse Generator for All Pulses: Rate ≤ 10MHz; $t_F$ ≤ 2ns; $t_R$ ≤ 2ns.

## SWITCH POSITION

| Test | Switch |
|---|---|
| Open Drain<br>Disable Low<br>Enable Low | $V_{LOAD}$ |
| Disable High<br>Enable High | GND |
| All Other Tests | Open |




$t_{SK(x)} = |t_{PLH2} - t_{PLH1}|$ or $|t_{PHL2} - t_{PHL1}|$

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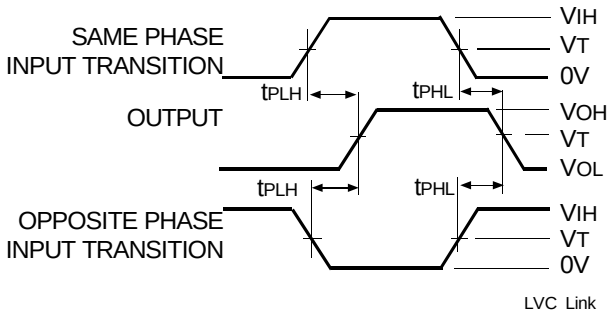
***Output Skew - $t_{SK(x)}$***

**NOTES:**

1. For $t_{SK(o)}$ OUTPUT1 and OUTPUT2 are any two outputs.
2. For $t_{SK(b)}$ OUTPUT1 and OUTPUT2 are in the same bank.

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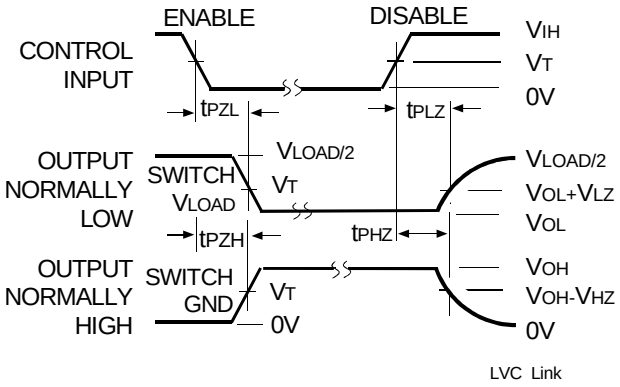
***Propagation Delay***

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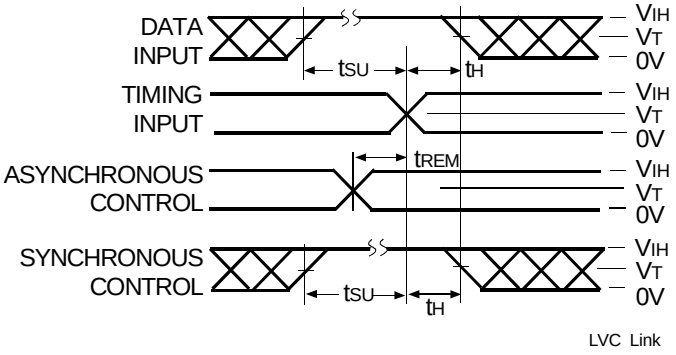
***Enable and Disable Times***

**NOTE:**

1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.

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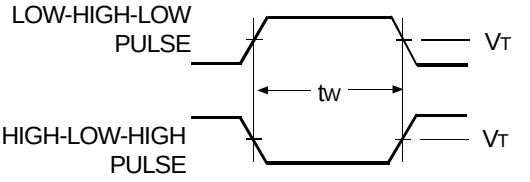
***Set-up, Hold, and Release Times***

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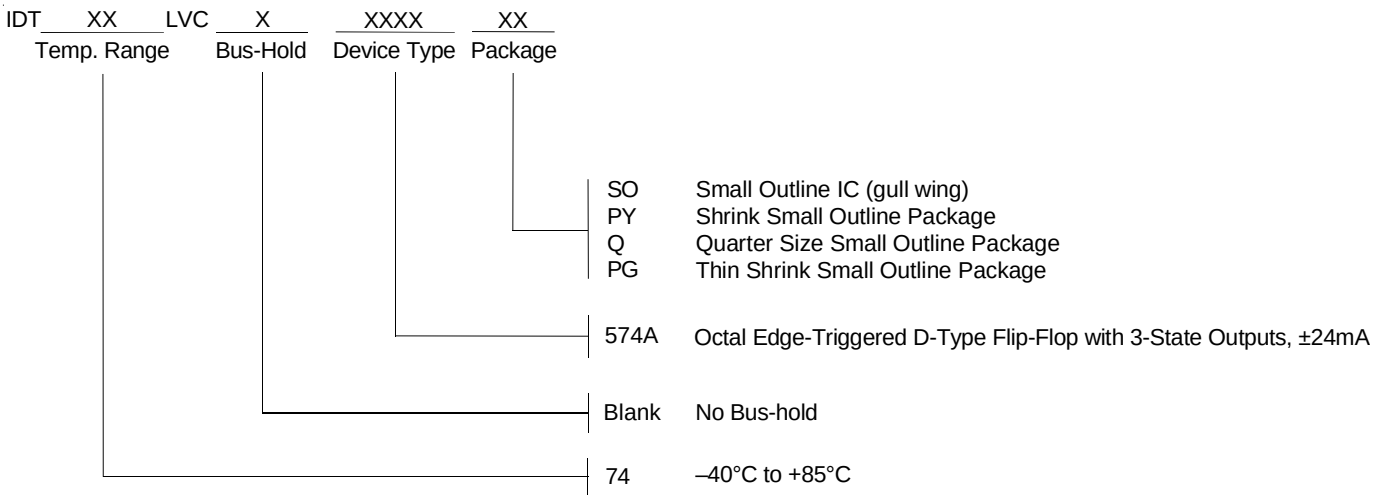
***Pulse Width***

## ORDERING INFORMATION

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